

policants: Mark L. Jenson et al.

Examiner:

Jonathan Crepeau

Serial No.:

10/807,214

Group Art Unit:

1746

Filed:

March 22, 2004

Docket:

1327.008US2

Title: METHOD AND APPARATUS FOR INTEGRATED BATTERY-CAPACITOR DEVICES

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

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X An <u>Information Disclosure Statement</u> (1 page);

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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Mark L. Jenson et al. Jonathan Crepeau Examiner:

1746 Serial No.: 10/807,214 Group Art Unit:

Attorney Docket: 1327.008US2 Filed: March 22, 2004 Title: METHOD AND APPARATUS FOR INTEGRATED BATTERY-CAPACITOR DEVICES

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

In compliance with the duty imposed by 37 C.F.R. § 1.56, and in accordance with 37 C.F.R. §§ 1.97 et. seq., the enclosed materials are brought to the attention of the Examiner for consideration in connection with the above-identified patent application. Applicants respectfully request that this Information Disclosure Statement be entered and the documents listed on the attached Form PTO/SB/08A (Substitute for Form 1449) be considered by the Examiner and made of record. Pursuant to the provisions of MPEP 609, Applicants request that a copy of the PTO/SB/08A form, initialed as being considered by the Examiner, be returned to the Applicants with the next official communication.

Pursuant to the sua sponte "Waiver of Copy Requirements" issued by the USPTO September 21, 2004, copies of cited U.S. patent applications are not required to be provided with an IDS for applications stored in the USPTO's IFW system. If copies of cited U.S. patent applications or U.S. issued patents are required for this application, please notify the Applicants' Representative.

Pursuant to 37 C.F.R. §1.97(b), Applicants believe that no fee is due for this Information Disclosure Statement. Please charge any additional fees or credit any overpayment to Deposit Account No. 502931. The Examiner is invited to contact the Applicants' Representative at the below-listed telephone number if there are any questions regarding this communication.

> Respectfully submitted, MARK L. JENSON ET AL. By their Representatives,

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der the Paperwork Reduction Act of 1935, no persons are required to respend to a conce Complete if Known Substitute for form 1449A/PTO INFORMATION DISCLOSURE **Application Number** 10/807,214 STATEMENT BY APPLICANT **Filing Date** March 22, 2004 (Use as many sheets as necessary) **First Named Inventor** Mark L. Jenson **Group Art Unit** 1746 **Examiner Name** Jonathan Crepeau NOV 3 0 2004 Attorney Docket No: 1327.008US2

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	Group Art Unit	1746
	Examiner Name	Jonathan Crepeau
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Substitute for form 1449A/PTO	Complete if Known	required to respect to a califed an of information unless it contains a val of QUIB control number.	
INFORMATION DISCLOSURE	Application Number	10/807,214	
STATEMENT BY APPLICANT (Use as many sheets as necessary)	Filing Date	March 22, 2004	
	First Named Inventor	Mark L. Jenson	
	Group Art Unit	1746	
	Examiner Name	Jonathan Crepeau	
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Sheet 5 of 6	Attorney Docket No: 1	327.008US2

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